Search Notes



| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|--|
| 10598529 | HAMANAKA, MASAHIKO |
| Examiner | Art Unit |
| STEDHEN D KOZIOI | 2624 |

| SEARCHED | | | |
|----------|----------|-----------|----------|
| Class | Subclass | Date | Examiner |
| 382 | 106, 118 | 8/10/2010 | srk |

| SEARCH NOTES | | |
|---|-----------|----------|
| Search Notes | Date | Examiner |
| PALM inventor name double patenting search | 8/10/2010 | srk |
| EAST text search of above-cited classes for object pose estimation using weighted sharpness differences | 8/10/2010 | srk |
| NPL IEEE search for object pose estimation using weighted sharpness differences | 8/10/2010 | srk |
| JPO patent and utility model gazette db abstract search for object pose estimation using weighted sharpness differences | 8/10/2010 | srk |

| INTERFERENCE SEARCH | | | |
|---------------------|----------|------|----------|
| Class | Subclass | Date | Examiner |
| | | | |

| /STEPHEN R KOZIOL/ Examiner.Art Unit 2624 | |
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